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October 2014

# FGH40N60SMD 600 V, 40 A Field Stop IGBT

### **Features**

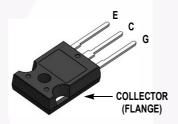
- Maximum Junction Temperature : T<sub>J</sub> = 175°C
- Positive Temperaure Co-efficient for Easy Parallel Operating
- · High Current Capability
- Low Saturation Voltage:  $V_{CE(sat)}$  = 1.9 V(Typ.) @  $I_C$  = 40 A
- · High Input Impedance
- Fast Switching: E<sub>OFF</sub> = 6.5 uJ/A
- · Tighten Parameter Distribution
- · RoHS Compliant

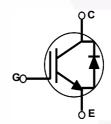
### **Applications**

· Solar Inverter, UPS, Welder, PFC, Telecom, ESS

## **General Description**

Using novel field stop IGBT technology, Fairchild's new series of field stop 2<sup>nd</sup> generation IGBTs offer the optimum performance for solar inverter, UPS, welder, telecom, ESS and PFC applications where low conduction and switching losses are essential.





## **Absolute Maximum Ratings**

Symbol	Description		Ratings	Unit
V <sub>CES</sub>	Collector to Emitter Voltage		600	V
V <sub>GES</sub>	Gate to Emitter Voltage		± 20	V
	Transient Gate to Emitter Voltage		± 30	V
lo.	Collector Current	@ T <sub>C</sub> = 25°C	80	A
lc	Collector Current	@ T <sub>C</sub> = 100°C	40	Α
I <sub>CM (1)</sub>	Pulsed Collector Current @ T <sub>C</sub> = 25°C		120	Α
I <sub>F</sub>	Diode Forward Current	@ T <sub>C</sub> = 25°C	40	Α
	Diode Forward Current	@ T <sub>C</sub> = 100°C	20	Α
I <sub>FM (1)</sub>	Pulsed Diode Maximum Forward Cur	rent	120	Α
P <sub>D</sub>	Maximum Power Dissipation	@ T <sub>C</sub> = 25°C	349	W
י ט	Maximum Power Dissipation	@ T <sub>C</sub> = 100°C	174	W
T <sub>J</sub>	Operating Junction Temperature		-55 to +175	°C
T <sub>stg</sub>	Storage Temperature Range		-55 to +175	°C
T <sub>L</sub>	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 secon	nds	300	°C

### Notes

1: Repetitive rating: Pulse width limited by max. junction temperature

### **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction to Case	-	0.43	°C/W
$R_{\theta JC}(Diode)$	Thermal Resistance, Junction to Case	-	1.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	-	40	°C/W

# **Package Marking and Ordering Information**

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FGH40N60SMD	FGH40N60SMD	TO-247	Tube	N/A	N/A	30

# Electrical Characteristics of the IGBT T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	teristics					
BV <sub>CES</sub>	Collector to Emitter Breakdown Voltage	$V_{GE} = 0 \text{ V}, I_{C} = 250 \mu\text{A}$	600	-	-	V
$\frac{\Delta BV_{CES}}{\Delta T_{J}}$	Temperature Coefficient of Breakdown Voltage	$V_{GE} = 0 \text{ V, } I_{C} = 250 \mu\text{A}$	-	0.6	-	V/°C
I <sub>CES</sub>	Collector Cut-Off Current	V <sub>CE</sub> = V <sub>CES</sub> , V <sub>GE</sub> = 0 V	- \	, -	250	μΑ
I <sub>GES</sub>	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0 V$	-	-	± 400	nA
On Charac	teristics					
V <sub>GE(th)</sub>	G-E Threshold Voltage	$I_C = 250  \mu A,  V_{CE} = V_{GE}$	3.5	4.5	6.0	V
- (- /		I <sub>C</sub> = 40 A, V <sub>GE</sub> = 15 V	-	1.9	2.5	V
V <sub>CE(sat)</sub>	Collector to Emitter Saturation Voltage	I <sub>C</sub> = 40 A, V <sub>GE</sub> = 15 V, T <sub>C</sub> = 175°C	-	2.1	-	V
Dynamic C	haracteristics		•			
C <sub>ies</sub>	Input Capacitance		-	1880	-	pF
C <sub>oes</sub>	Output Capacitance	$V_{CE} = 30 \text{ V}, V_{GE} = 0 \text{ V},$ f = 1  MHz	-	180	-	pF
C <sub>res</sub>	Reverse Transfer Capacitance	-1 - 1 1011 12	-	50	-	pF
Switching	Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time		-	12	16	ns
t <sub>r</sub>	Rise Time		-	20	28	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>CC</sub> = 400 V, I <sub>C</sub> = 40 A,	-	92	120	ns
t <sub>f</sub>	Fall Time	$R_G = 6 \Omega$ , $V_{GE} = 15 V$ ,	-	13	17	ns
E <sub>on</sub>	Turn-On Switching Loss	Inductive Load, T <sub>C</sub> = 25°C	-	0.87	1.30	mJ
E <sub>off</sub>	Turn-Off Switching Loss		-	0.26	0.34	mJ
E <sub>ts</sub>	Total Switching Loss		-	1.13	1.64	mJ
t <sub>d(on)</sub>	Turn-On Delay Time		-	15	-	ns
t <sub>r</sub>	Rise Time		-	22	-	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{CC} = 400 \text{ V}, I_{C} = 40 \text{ A},$ $R_{G} = 6 \Omega, V_{GE} = 15 \text{ V},$	-	116	-	ns
t <sub>f</sub>	Fall Time		-	16	-	ns
E <sub>on</sub>	Turn-On Switching Loss	Inductive Load, T <sub>C</sub> = 175°C	-	0.97	-	mJ
E <sub>off</sub>	Turn-Off Switching Loss		-	0.60	-	mJ
E <sub>ts</sub>	Total Switching Loss	1	-	1.57	-	mJ

## **Electrical Characteristics of the IGBT** (Continued)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max	Unit
$Q_g$	Total Gate Charge		-	119	180	nC
Q <sub>ge</sub>	Gate to Emitter Charge	V <sub>CE</sub> = 400 V, I <sub>C</sub> = 40 A, V <sub>GE</sub> = 15 V	-	13	20	nC
Q <sub>gc</sub>	Gate to Collector Charge	V GE - 10 V	-	58	90	nC

# Electrical Characteristics of the Diode T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter	Test Condition	ons	Min.	Тур.	Max	Unit
V <sub>FM</sub>	Diode Forward Voltage	I <sub>E</sub> = 20 A	$T_{\rm C} = 25^{\rm o}{\rm C}$	-	2.3	2.8	V
FM	Blode i olwara voltage	1F 20 / (	$T_{\rm C} = 175^{\rm o}{\rm C}$	-	1.67	-	•
E <sub>rec</sub>	Reverse Recovery Energy		T <sub>C</sub> = 175°C	-	48.9	-	uJ
t <sub>rr</sub>	Diode Reverse Recovery Time	$I_F = 20 \text{ A}, dI_F/dt = 200 \text{ A/}\mu\text{s}$	$T_C = 25^{\circ}C$	/ -	36	-	ns
भा			$T_{\rm C} = 175^{\rm o}{\rm C}$	-	110	-	
Q <sub>rr</sub>	Diode Reverse Recovery Charge		$T_C = 25^{\circ}C$	-	46.8	-	nC
~ I	2.000 riororos riosorory emange		$T_{\rm C} = 175^{\rm o}{\rm C}$	-	445	-	

**Figure 1. Typical Output Characteristics** 

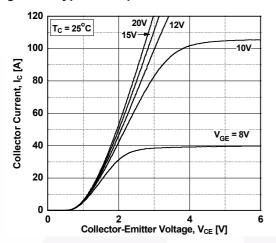


Figure 3. Typical Saturation Voltage Characteristics

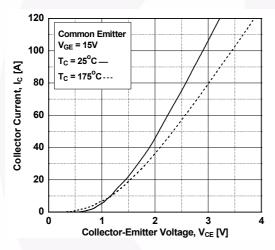
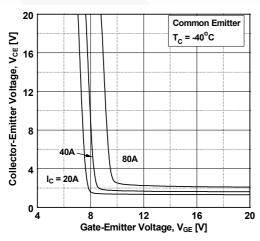


Figure 5. Saturation Voltage vs. V<sub>GE</sub>



**Figure 2. Typical Output Characteristics** 

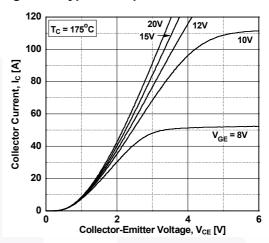


Figure 4. Saturation Voltage vs. Case
Temperature at Variant Current Level

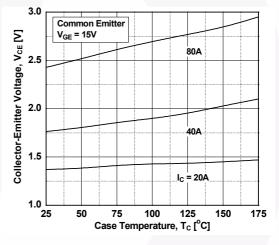


Figure 6. Saturation Voltage vs. V<sub>GE</sub>

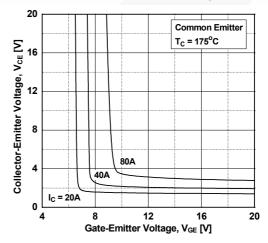


Figure 7. Capacitance Characteristics

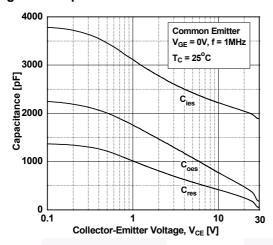


Figure 8. Gate charge Characteristics

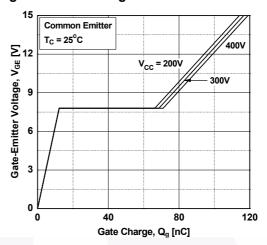


Figure 9. Turn-on Characteristics vs.
Gate Resistance

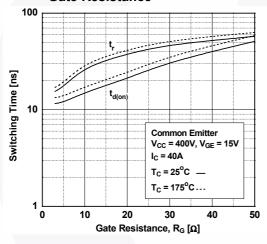


Figure 10. Turn-off Characteristics vs.
Gate Resistance

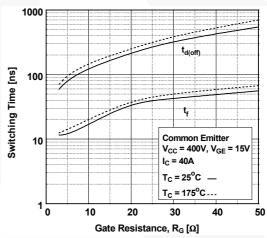


Figure 11. Switching Loss vs.
Gate Resistance

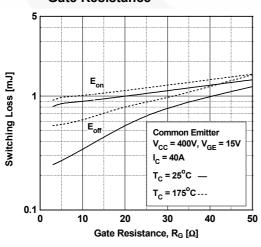


Figure 12. Turn-on Characteristics vs. Collector Current

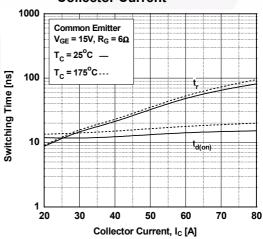


Figure 13. Turn-off Characteristics vs. Collector Current

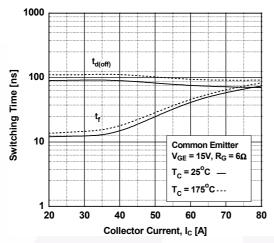


Figure 15. Load Current Vs. Frequency

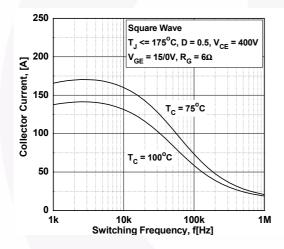


Figure 17. Forward Characteristics

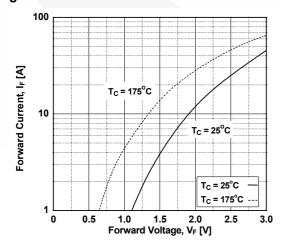


Figure 14. Switching Loss vs. Collector Current

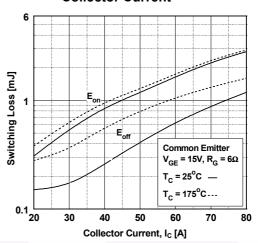


Figure 16. SOA Characteristics

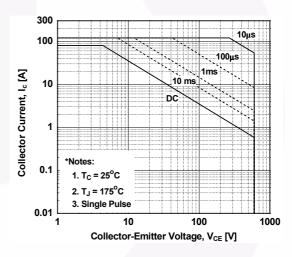


Figure 18. Reverse Recovery Current

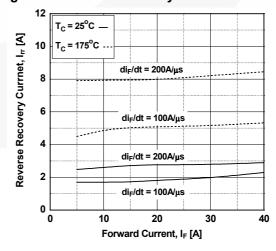


Figure 19. Reverse Recovery Time

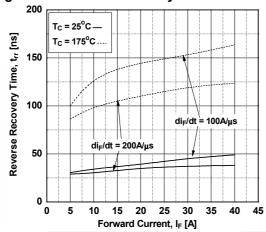


Figure 20. Stored Charge

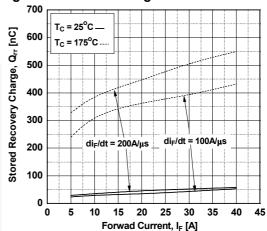


Figure 21. Transient Thermal Impedance of IGBT

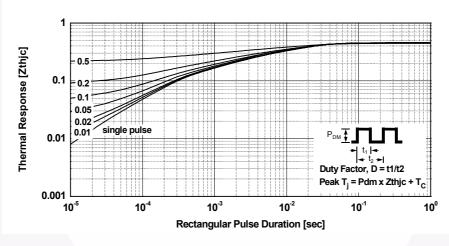
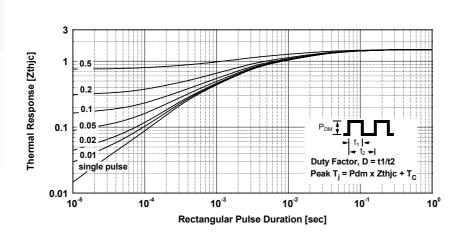
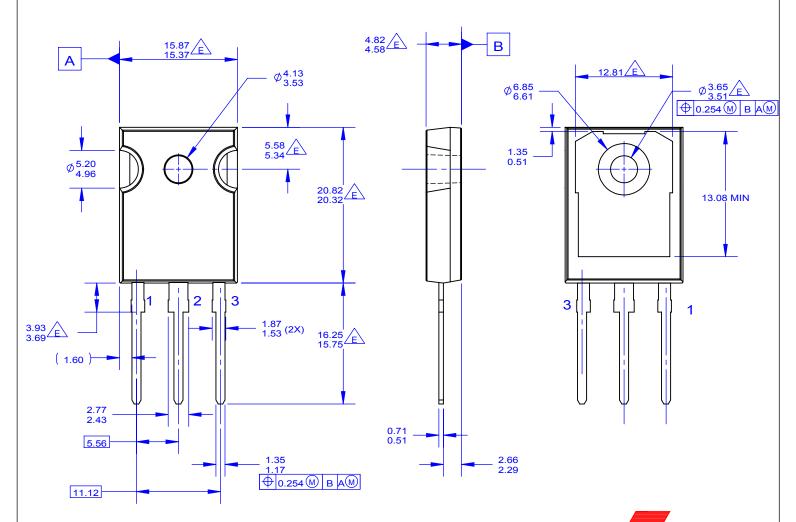


Figure 22. Time Transient Thermal Impedance of Diode







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